


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594415	<b>Applicant(s)/Patent Under Reexamination</b>  VIERA, PEDRO QUEIROZ
	<b>Examiner</b>  SANG Y PAIK	<b>Art Unit</b>  3742

SEARCHED			
Class	Subclass	Date	Examiner
392	386-406	9/16/09	sp
239	34-60	9/16/09	sp
219	385, 391-401	9/16/09	sp

SEARCH NOTES		
Search Notes	Date	Examiner
east searched	9/16/09	sp

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--